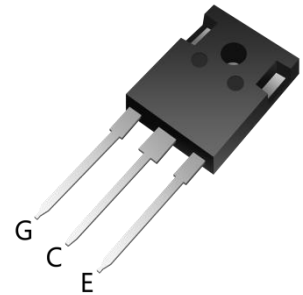
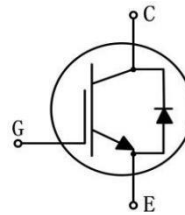


Trench Field-stop IGBT Discrete

Parameter	Value	Unit
V_{CE}	650	V
I_c	40	A
$V_{CE(sat)}$	1.65	V



TO-247-3L

Features

- Positive temperature coefficient
- Fast Switching
- Low $V_{CE(sat)}$
- Reliable and Rugged

Applications

- Motor drives
- Solar inverter
- Resonant converters

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CES}	650	V
Gate-emitter voltage	V_{GES}	± 30	V
Continuous collector current (TC=25°C)	IC	80	A
Continuous collector current (TC=100°C)		40	A
Pulsed collector current, tp limited by T_{vjmax}	ICM	160	A
Diode continuous forward current (TC=25°C)	IF	80	A
Diode continuous forward current (TC=100°C)		40	A
Diode maximum current, tp limited by T_{vjmax}	IFM	160	A
Operating junction temperature range	T_{vj}	-55 to +175	°C
Storage temperature range	T_{stg}	-55 to +175	°C

Thermal characteristics

Parameter	Symbol	Typ	Max.	Unit
Thermal resistance, junction to case for IGBT	$R_{th(j-c)}$	-	0.66	K/ W
Thermal resistance, junction to case for Diode	$R_{th(j-c)}$	-	0.58	K/ W

Thermal resistance, junction to ambient	Rth(j-a)	-	40	K/ W
---	----------	---	----	------

Note1:Pulse test: 300 μs pulse width, 2 % duty cycle

Electrical characteristics of IGBT at Tvj=25°C unless otherwise specified
Static characteristics

Parameter	Test Condition	Symbol	Min	Typ	Max	Unit
Collector-emitter breakdown voltage	VGE=0V, IC=250μA	BVCES	650	-	-	V
Collector-emitter leakage current	VCE=650V, VGE=0V	ICES	-	-	10	μA
Gate leakage current, forward	VGE=±20V, VCE=0V	IGES	-	-	±200	nA
Gate-emitter threshold voltage	VGE=VCE, IC=1mA	VGE(th)	4.3	5.3	6.3	V
Collector-emitter saturation voltage	VGE=15 V, IC=40A	VCE(sat)	-	1.65	1.95	V
	VGE=15V, IC=40A, Tvj=125°C		-	2	-	V
	VGE=15V, IC=40A, Tvj=175°C		-	2.15	-	V

Dynamic characteristics

Parameter	Test Condition	Symbol	Min	Typ	Max	Unit
Input capacitance	VCE=25V, VGE=0V f =1MHz	Cies	-	2540	-	pF
Output capacitance		Coes	-	126	-	pF
Reverse transfer capacitance		Cres	-	67	-	pF
Total gate charge	VCC=520V, VGE=15V IC=40A	Qg	-	146	-	nC
Gate- Emitter Charge		Qge	-	24	-	nC
Gate- Collector Charge		Qgc	-	71	-	nC
Short circuit collector current Max.1000 short circuits, times between short circuits: ≥ 1.0s	VGE=15V, VCC≤400V TJ≤175°C	t(SC)	-	8	-	μs

Electrical characteristics of IGBT at Tvj=25°C unless otherwise specified
Switching characteristics

Parameter	Test Condition	Symbol	Min	Typ	Max	Unit
Turn-on delay time	VCC=400V VGE=15V IC=40A RG=5Ω Inductive load	td(on)	-	20	-	ns
Rise time		tr	-	67	-	ns
Turn-off delay time		td(off)	-	104	-	ns
Fall time		tf	-	74	-	ns
Turn-on energy		Eon	-	0.95	-	mJ

Turn-off energy	VCC=400V VGE=15V IC=40A RG=5Ω Inductive load Tvj=175°C	Eoff	-	0.93	-	mJ
Total switching energy		Ets	-	1.88	-	mJ
Turn-on delay time		td(on)	-	22	-	ns
Rise time		tr	-	73	-	ns
Turn-off delay time		td(off)	-	178	-	ns
Fall time		tf	-	70	-	ns
Turn-on energy		Eon	-	1.82	-	mJ
Turn-off energy		Eoff	-	1.16	-	mJ
Total switching energy		Ets	-	2.98	-	mJ

Electrical characteristics of Diode at Tvj=25°C unless otherwise specified

Parameter	Test Condition	Symbol	Min	Typ	Max	Unit
Diode forward voltage	IF=40A IF=40A Tvj=125°C IF=40A Tvj=175°C	VF	-	2.2	2.55	V
			-	1.84	-	V
			-	1.62	-	V
Diode reverse recovery time	VR=400V IF=40A diF/dt=-200A/μs	trr	-	188	-	ns
Diode peak reverse recovery current		Qrr	-	243	-	nC
Diode reverse recovery charge		Irrm	-	6.8	-	A
Diode reverse recovery time	VR=400V IF=40A diF/dt=-200A/μs Tvj=175°C	trr	-	215	-	ns
Diode peak reverse recovery current		Qrr	-	278	-	nC
Diode reverse recovery charge		Irrm	-	9.7	-	A

Typical Characteristics

Figure 1: Power Dissipation

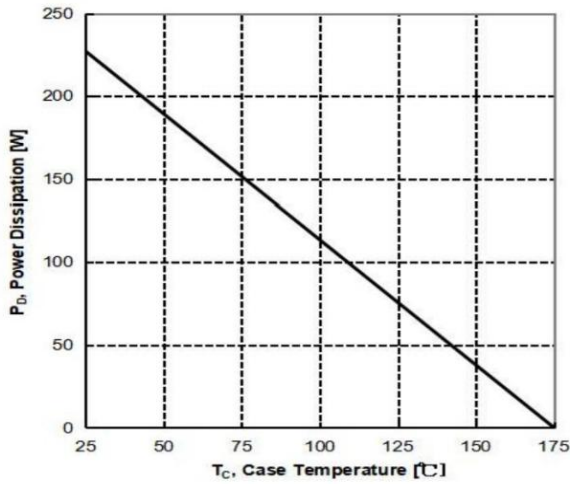


Figure 2: Collector Current vs. Case Temperature

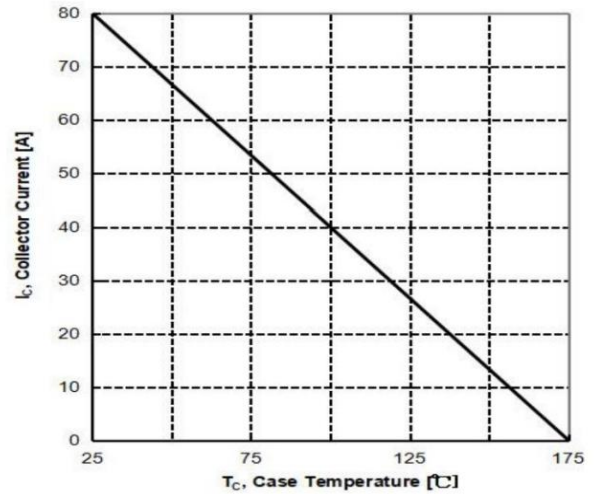


Figure 3: Safe Operation Area

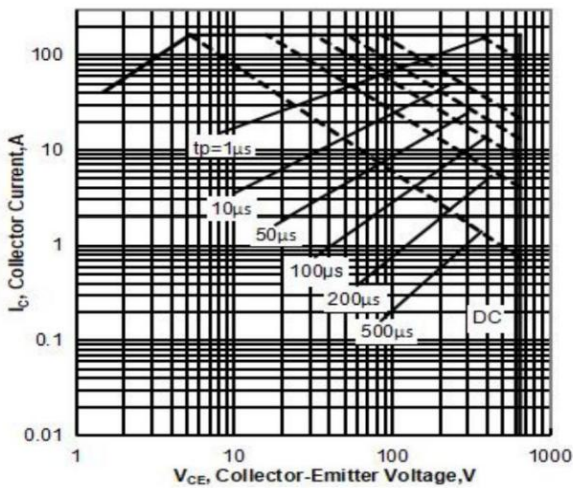


Figure 4: Typical Transfer Characteristics

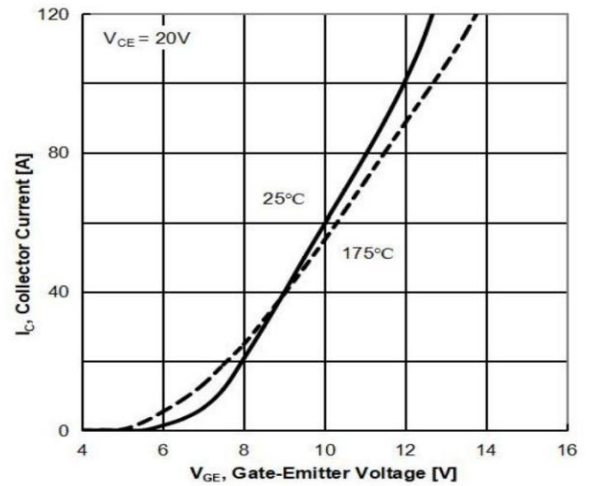


Figure 5: Typical Output Characteristics

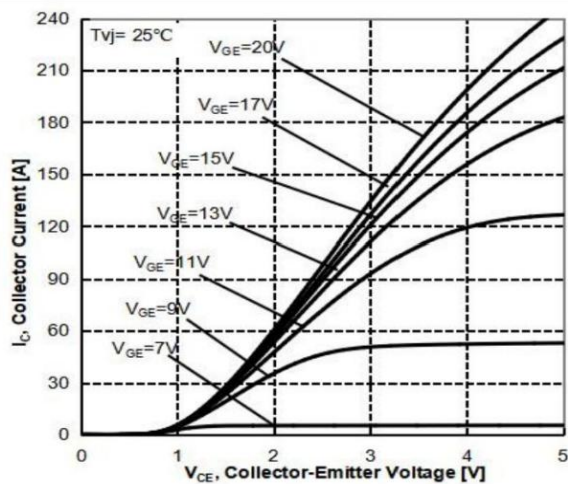


Figure 6: Typical Output Characteristics

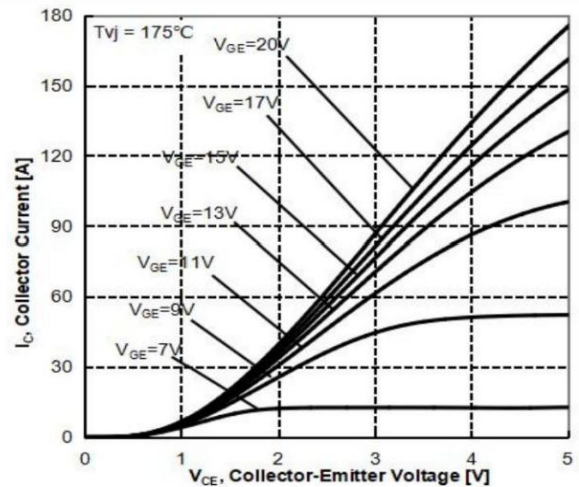


Figure 7: Typical Collector-Emitter Saturation Voltage vs. Junction Temperature

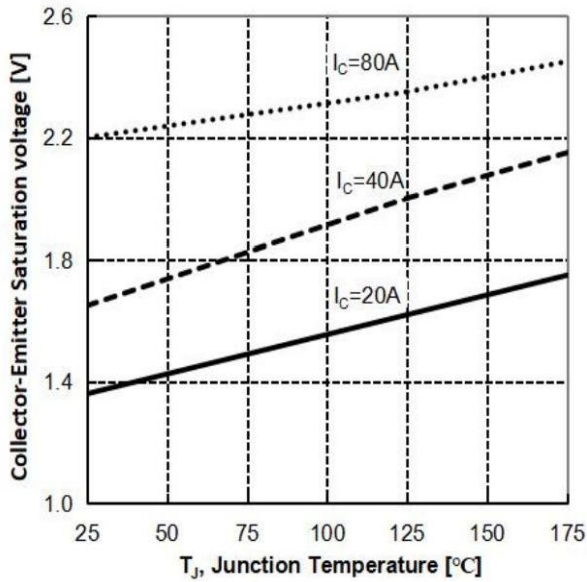


Figure 8: Typical Gate-Emitter Threshold Voltage vs. Junction Temperature

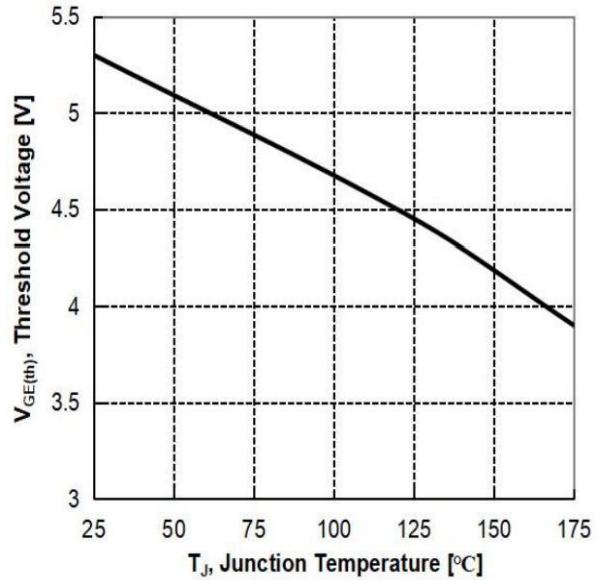


Figure 9: Typical Switching Times vs. Gate Resistor ($T_J=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=40A$)

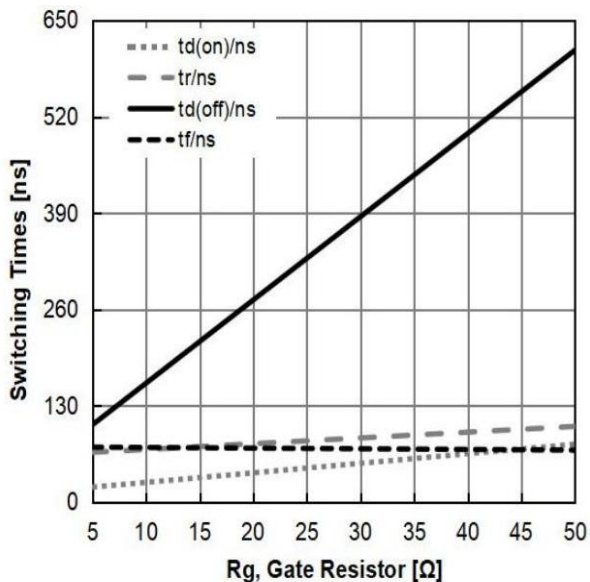


Figure 10: Typical Switching Energy vs. Gate Resistor ($T_J=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=40A$)

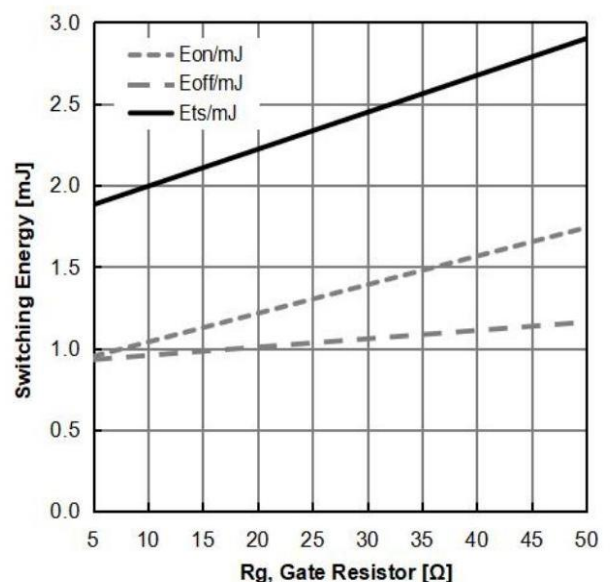


Figure 11: Typical Switching Times vs. Junction Temperature ($V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=40A$)

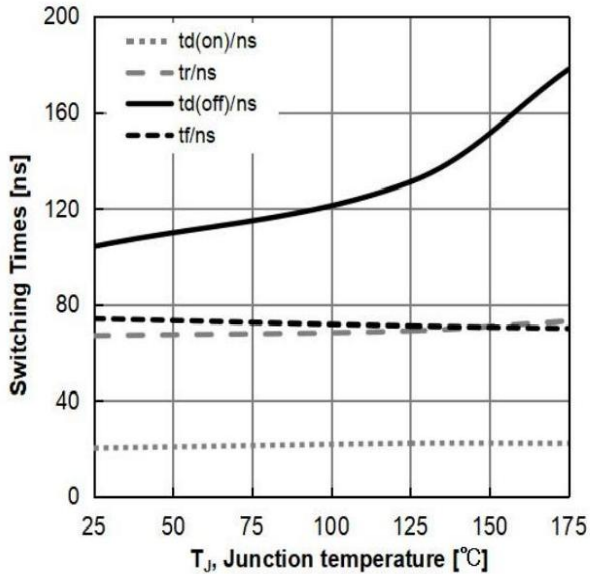


Figure 12: Typical Switching Energy vs. Junction Temperature ($V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=40A$)

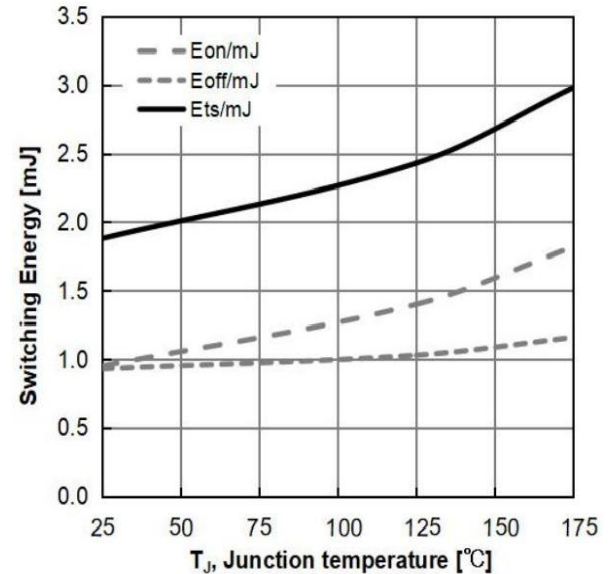


Figure 13: Typical Switching Times vs. Collector Current ($T_J=25°C$, $V_{CE}=400V$, $V_{GE}=15/0V$)

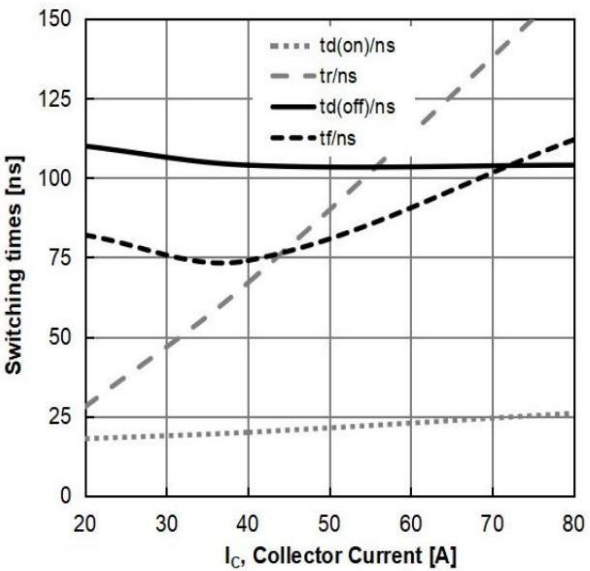


Figure 14: Typical Switching Energy vs. Collector Current ($T_J=25°C$, $V_{CE}=400V$, $V_{GE}=15/0V$)

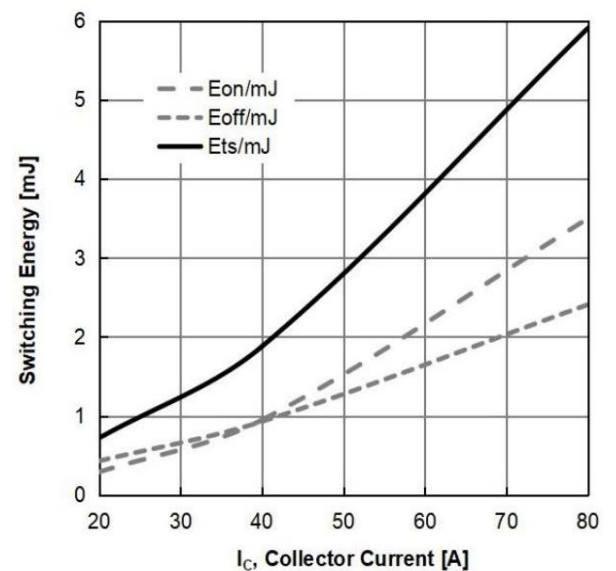


Figure 15: Typical Switching Times vs. VCE ($T_J=25^{\circ}\text{C}, V_{GE}=15/0\text{V}, I_C=40\text{A}$)

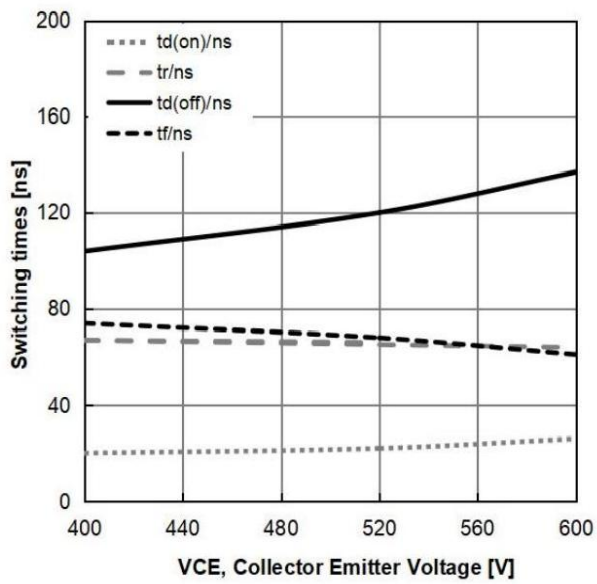


Figure 16: Typical Switching Energy vs. VCE ($T_J=25^{\circ}\text{C}, V_{GE}=15/0\text{V}, I_C=40\text{A}$)

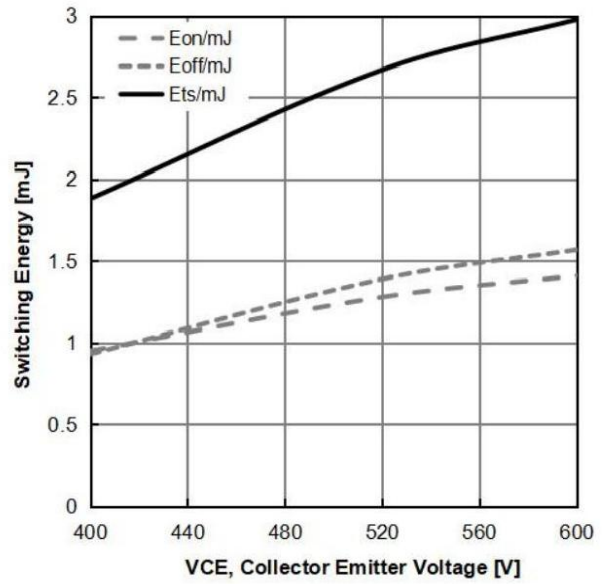


Figure 17: Typical Gate Charge

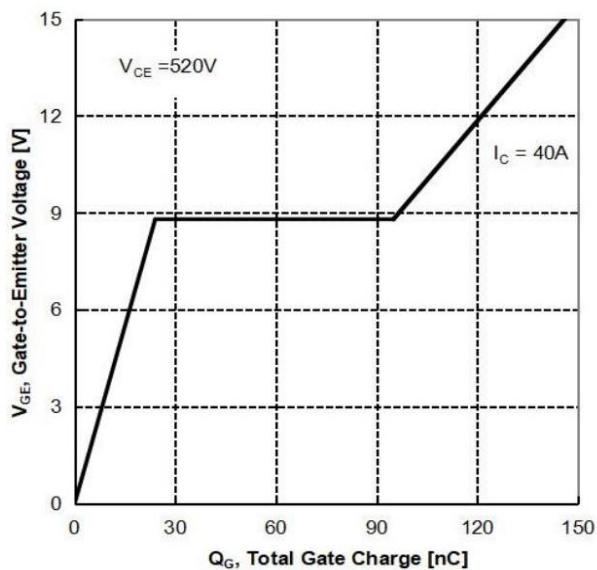


Figure 18: Typical Capacitance vs. Collector- Emitter Voltage

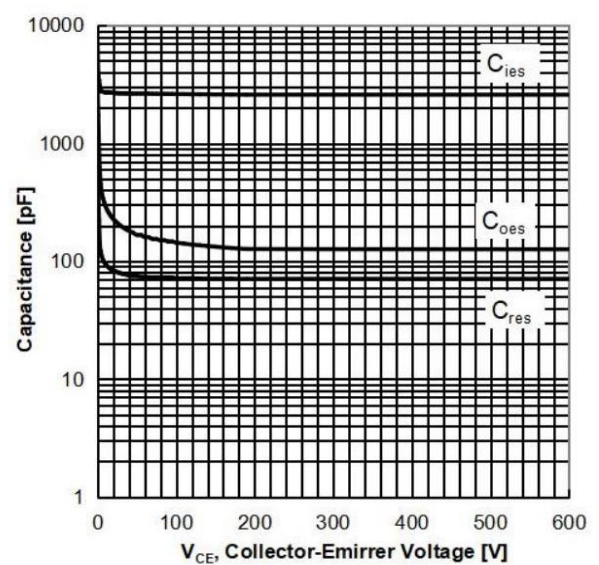


Figure 19: IGBT Transient Thermal Impedance vs. Pulse Width

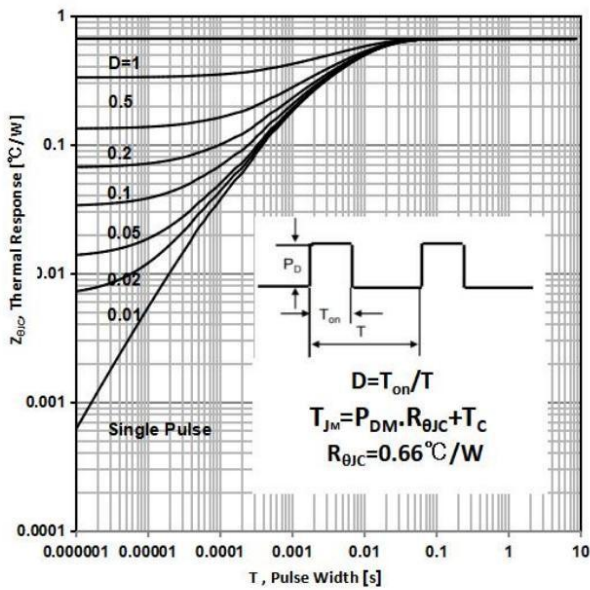


Figure 20: Diode Transient Thermal Impedance vs. Pulse Width

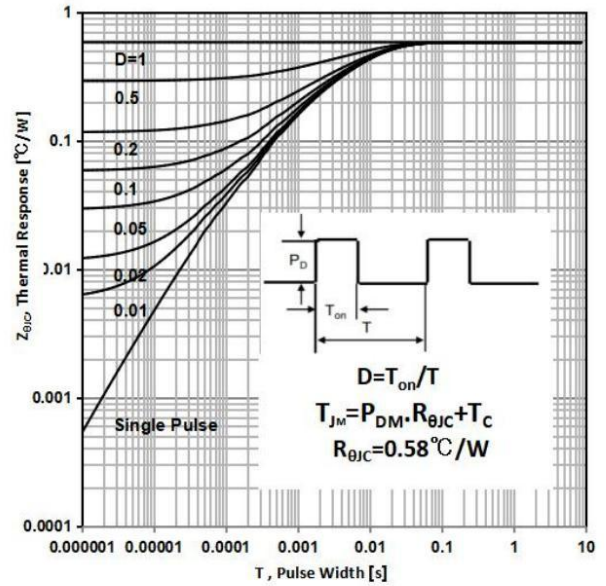
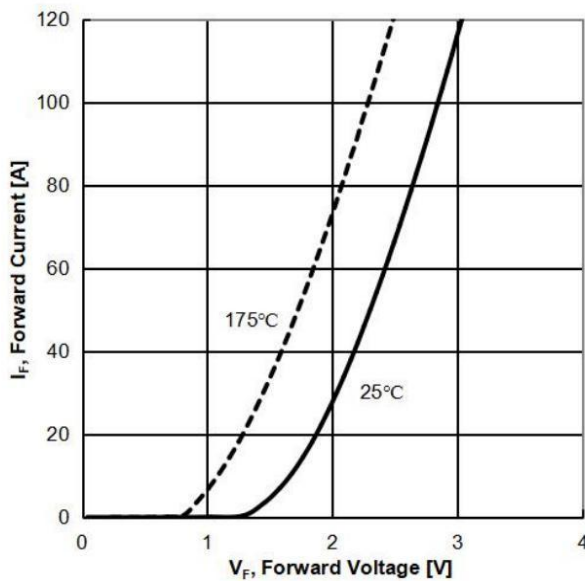
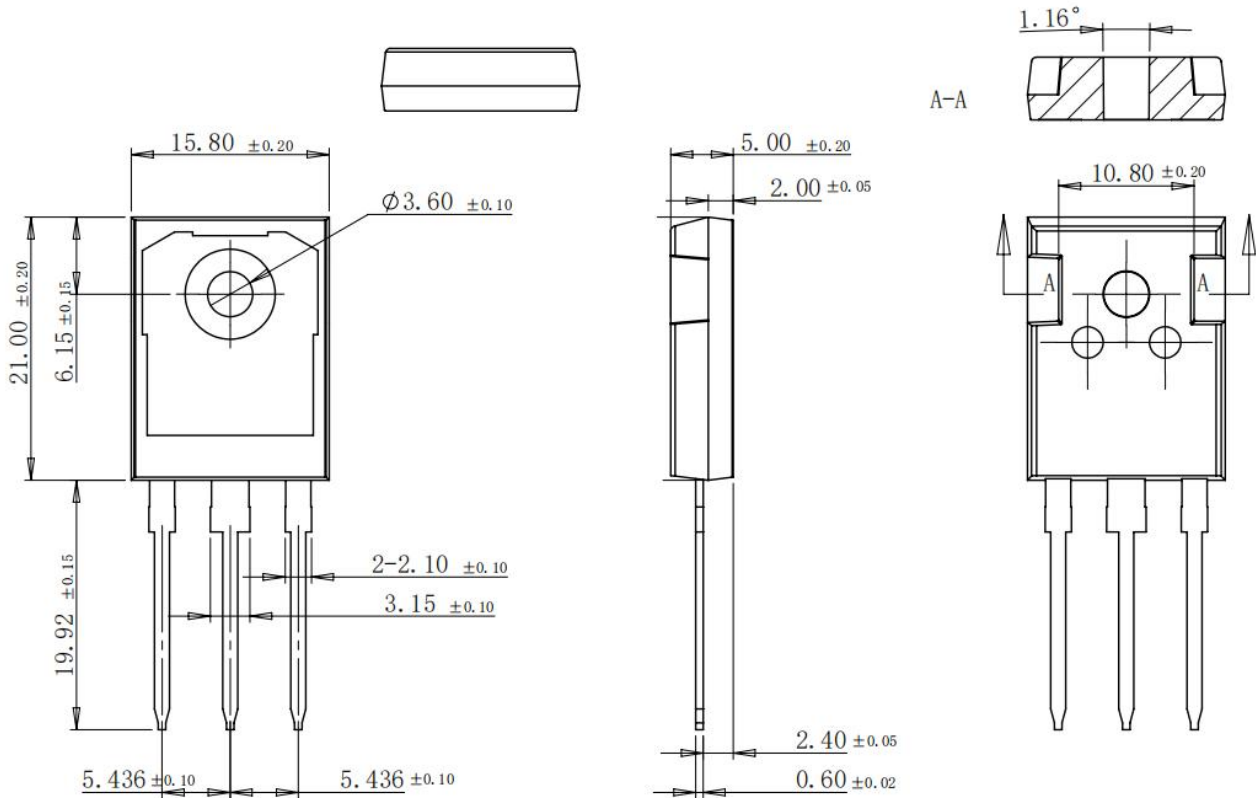


Figure 21: Typical Diode Forward Current vs. Forward Voltage



Package Outlines (Unit: mm)

TO-247-3L



***Important Usage Information and Disclaimer**

The specifications of Zhuhai Hypersemi Co., Ltd. products are not guarantees of product characteristics. They reflect typical performance expected in standard applications, which may vary with specific uses. Users must conduct prior testing for their applications and make necessary adjustments.

Users are responsible for the safety of applications utilizing our products and must implement adequate safety measures to prevent physical injury, fire, or other risks in case of product failure. It is the user's duty to ensure that application designs comply with all applicable laws and standards. Our products must not be used in any applications where a product failure could reasonably result in personal injury, unless specifically authorized in a signed document by Zhuhai Hypersemi Co., Ltd.

No representations or warranties are made regarding the accuracy or completeness of this information, including any claims of non-infringement of third-party intellectual property rights. Zhuhai Hypersemi Co., Ltd. assumes no liability for any applications or uses of its products and does not grant any licenses to its intellectual property rights or those of others. We also make no claims regarding non-infringement of third-party intellectual property rights that may arise from applications.

Due to technical requirements, our products may contain hazardous substances. For details, please contact your nearest sales office. This document replaces all previous information and may be updated. We reserve the right to make changes.